

	Hits	Search Text	DBs
1	6421424	gap\$4 or spac\$4 or open\$6 or slit\$4 or crack\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
2	123388	(i-layer or intrinsic or (i adj layer))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
3	64554	(imag\$4 or light\$4 or UV or ultraviolet or ultra-violet or IR or infrared) near4 (photosens\$4 or photo-sens\$4 or photodetect\$4 or photo-detect\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
4	9370	(PIN or P-i-n or pi-n or pi-n) near2 diode	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
5	1597839	(cross near2 talk\$4) or interfer\$6 or smear\$6 or nois\$4 or disturb\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
6	10090	PIN near4 diode	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
7	1843344	sensor or detector	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
8	1798	(PIN near4 diode) same (sensor or detector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
9	67	((PIN near4 diode) same (sensor or detector)) same (cross-talk\$4 or (cross adj talk\$4) or interfer\$4 or smear\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
10	1829648	wafer or substrate	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
11	611	((PIN near4 diode) same (sensor or detector)) and (wafer or substrate)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
12	798137	cross-talk\$4 or (cross adj talk\$4) or interfer\$4 or smear\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB

	Time Stamp
1	2004/03/03 14:29
2	2004/03/03 14:30
3	2004/03/03 14:31
4	2004/03/03 14:33
5	2004/03/03 14:34
6	2004/03/03 14:36
7	2004/03/03 14:36
8	2004/03/03 14:36
9	2004/03/03 14:37
10	2004/03/03 14:37
11	2004/03/03 14:39
12	2004/03/03 14:39

	Hits	Search Text	DBs
13	236	((PIN near4 diode) same (sensor or detector)) and (wafer or substrate)) and (cross-talk\$4 or (cross adj talk\$4) or interfer\$4 or smear\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
14	31	(gap\$4 or spac\$4 or open\$6 or slit\$4 or crack\$4) same ((i-layer or intrinsic or (i adj layer))) same ((imag\$4 or light\$4 or UV or ultraviolet or ultra-violet or IR or infrared) near4 (photosens\$4 or photo-sens\$4 or photodetect\$4 or photo-detect\$4))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
15	7	(p-dop\$4 or (p adj dop\$4)) near4 (i-dop\$4 or (i adj dop\$4) or intrinsic or i-layer) near4 (n-dop\$4 or (n adj dop\$4)) near4 diode	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
16	808	((PIN or P-i-n or pi-n or pi-n) near2 diode) same ((cross near2 talk\$4) or interfer\$6 or smear\$6 or nois\$4 or disturb\$6)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
17	509	(438/48).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
18	1088	(257/461).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
19	314	((438/16).CCLS.) and (sensor or detector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
20	210	(438/325).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
21	165	(438/328).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB

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13	2004/03/03 14:40
14	2004/03/03 14:41
15	2004/03/03 14:42
16	2004/03/03 14:52
17	2004/03/03 14:59
18	2004/03/03 15:03
19	2004/03/03 15:05
20	2004/03/03 15:06
21	2004/03/03 15:38

	Hits	Search Text	DBs
22	185	(438/467).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
23	214	(257/444).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
24	877	(257/458).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
25	675	(257/459).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
26	368	(257/446).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
27	716	(257/448).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB

	Time Stamp
22	2004/03/03 15:42
23	2004/03/03 15:43
24	2004/03/03 17:09
25	2004/03/03 17:38
26	2004/03/03 18:00
27	2004/03/03 18:39

	Type	L #	Hits	Search Text	DBs	Time Stamp
1	IS&R	L1	395	(257/656) .CCLS.	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/03 19:46
2	IS&R	L2	137	(257/657) .CCLS.	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/03 20:00
3	IS&R	L5	1088	(257/461) .CCLS.	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/03 20:45